TOSHIBA PHOTOCOUPLER GaAs IRED & PHOTO-TRIAC

TLP3041(S),TLP3042(S),TLP3043(S)

OFFICE MACHINE HOUSEHOLD USE EQUIPMENT TRIAC DRIVER SOLID STATE RELAY

The TOSHIBA TLP3041 (S), TLP3042 (S), TLP3043 (S) consist of a zero voltage crossing turn-on photo-triac optically coupled to a gallium arsenide infrared emitting diode in a six lead plastic DIP package.

: 100 mA (max)

: SS EN60065

: 15 mA (max) (TLP3041(S)) 10 mA (max) (TLP3042(S)) 5 mA (max) (TLP3043(S))

SS EN60950, File No.9841109

: BS EN60065, File No.8385 BS EN60950, File No.8386

- Peak Off-State Voltage : 400 V (min)
- Trigger LED Current
- On-State Current
- Isolation Voltage
 - solation Voltage : 5000 Vrms (min) UL Recognized : UL1577, File No. E67349
- UL Recognized
- SEMKO Approved
- BSI Approved
- Option (D4) type

VDE approved: DIN EN60747-5-2

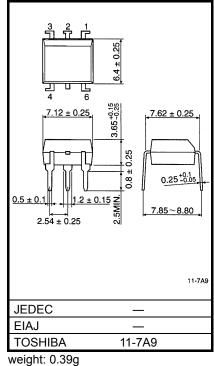
Approved No. 40009302

Maximum operating insulation voltage: 890VPK Highest permissible over voltage: 8000VPK

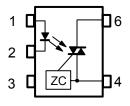
(Note):When a EN60747-5-2 approved type is needed, please designate the "Option (D4)"

• Construction mechanical rating

	7.62 mm pich Standard Type	10.16 mm pich TLPxxxxF Type		
Creepage Distance	7.0 mm (Min)	8.0 mm (Min)		
Clearance	7.0 mm (Min)	8.0 mm (Min)		
Insulation Thickness	0.5 mm (Min)	0.5 mm (Min)		



Pin Configuration (top view)



1: Anode 2: Cathode 3: N.C. 4:Terminal 1 6:Terminal 2

ZC:Zero-cross Circuit

Unit: mm

Absolute Maximum Ratings (Ta = 25°C)

CHARACTERISTIC			SYMBOL	RATING	UNIT		
	Forward Current		١ _F	50	mA		
	Forward Current Derating (Ta ≥ 53°C)		ΔI _F / °C	-0.7	mA / °C		
	Peak Forward Current (100µs pulse, 100pps)		I _{FP}	1	А		
LED	Power Dissipation		PD	100	mW		
	Power Dissipation Derating (Ta ≥ 25°C)		ΔP _D / °C	-1.0	mW / °C		
	Reverse Voltage		V _R	5	V		
	Junction Temperature		Тј	125	°C		
	Off-State Output Terminal Voltage		V _{DRM}	400	V		
	On-Stage RMS	Ta = 25°C		100	mA		
DETECTOR	Current	Ta = 70°C	I _{T(RMS)}	50	IIIA		
	On-State Current Derating (Ta ≥ 25°C)		ΔI _T / °C	-1.1	mA / °C		
	Peak On-Stage Current (100,4s pulse, 120pps)		I _{TP}	2	А		
DET	Peak Nonrepetitive Surge Current (P _W = 10ms, DC = 10%)		ITSM	1.2	А		
Power Dissipation			PD	300	mW		
	Power Dissipation Derating (Ta ≥ 25°C)		ΔP _D / °C	-4.0	mW / °C		
	Junction Temperature		Тј	115	°C		
Stora	age Temperature Range		T _{stg}	-55 ~ 150	°C		
Operating Temperature Range			T _{opr}	-40 ~ 100	°C		
Lead Soldering Temperature (10s)			T _{sol}	260	°C		
Total Package Power Dissipation			PT	330	mW		
Total Package Power Dissipation Derating (Ta ≥ 25°C)		ΔP _T / °C	-4.4	mW / °C			
	tion Voltage 1 min., R.H. ≤ 60%)	BVS	5000	Vrms			

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Device considered a two terminal device: Pins 1, 2 and 3 shorted together and pins 4 and 6 shorted together.

Recommended Operating Conditions

CHARACTERISTIC	SYMBOL	MIN	TYP.	MAX	UNIT
Supply Voltage	V _{AC}	—	—	120	Vac
Forward Current	IF*	15	20	25	mA
Peak On-Stage Current	I _{TP}	_	_	1	А
Operating Temperature	T _{opr}	-25		85	°C

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

^{*:} In the case of TLP3042

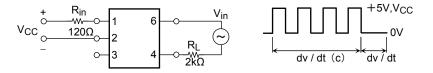
Individual Electrical Characteristics (Ta = 25°C)

	CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
	Forward Voltage	VF	I _F = 10mA	1.0	1.15	1.3	V
LED	Reverse Current	I _R	V _R = 5V	_	_	10	μA
	Capacitance	CT	V = 0, f = 1MHz	_	10	_	pF
~	Peak Off-State Current	I _{DRM}	V _{DRM} = 400V	_	10	100	nA
	Peak On-Stage Voltage	V _{TM}	I _{TM} = 100mA	_	1.7	3.0	V
CTO	Holding Current	Iн	_	_	0.6	_	mA
DETECTOR	Critical Rate of Rise of Off- State Voltage	dv / dt	V _{in} = 120Vrms, Ta = 85°C (Fig.1)	200	500	_	V / μs
	Critical Rate of Rise of Commutating Voltage	dv / dt(c)	V _{in} = 30Vrms, IT = 15mA (Fig.1)		0.2	_	V / μs

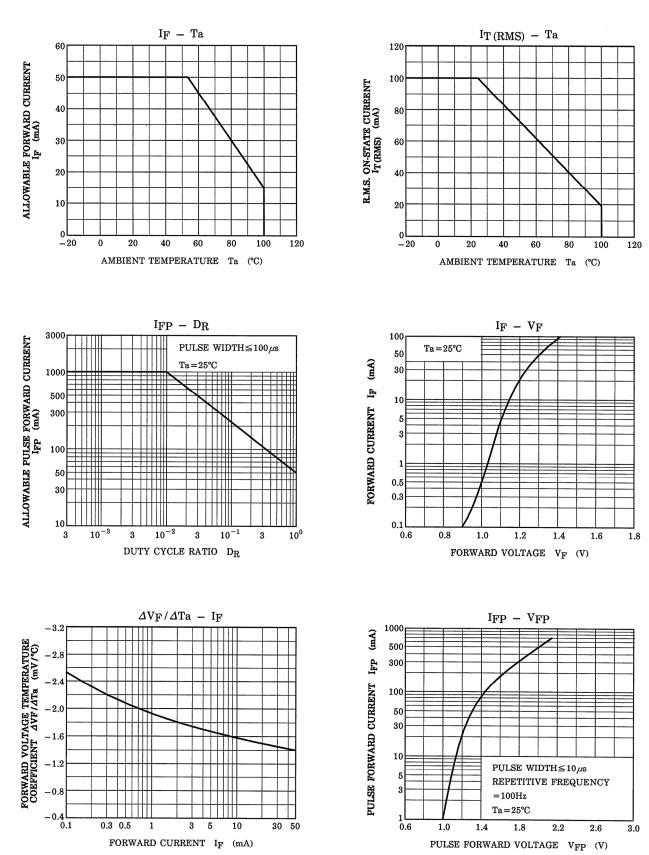
Coupled Electrical Characteristics (Ta = 25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Trigger LED Current	TLP3041(S)	I _{FT}	V _T = 3V	_	_	15	mA
	TLP3042(S)			_	5	10	
	TLP3043(S)				_	5	
Inhibit Voltage		VIH	I _F = Rated I _{FT}	_	_	40	V
Leakage in Inhibited State		ЦΗ	I _F = Rated I _{FT} V _T = Rated V _{DRM}	_	100	300	μA
Capacitance Input to Output		CS	V _S = 0, f = 1MHz	_	0.8		pF
Isolation Resistance		R _S	V _S = 500V (R.H. ≤ 60%)	5×10 ¹⁰	10 ¹⁴		Ω
Isolation Voltage		BVS	AC, 1 minute	5000	_	_	Vrms
			AC, 1 second (in oil)	_	10000	_	VIIIIS
			DC, 1 minute (in oil)		10000	_	Vdc

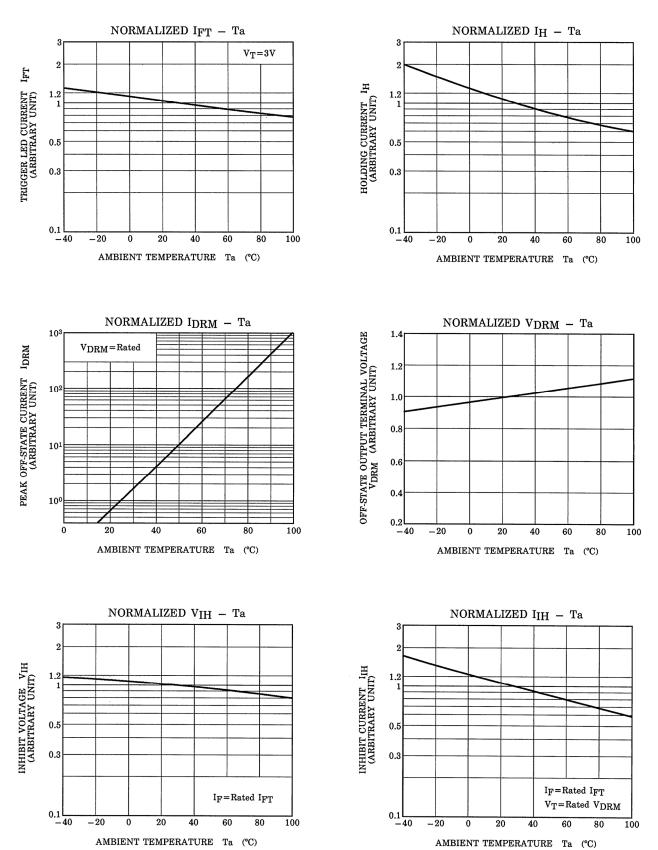
Fig. 1 dv / dt test circuit



TOSHIBA



TOSHIBA



RESTRICTIONS ON PRODUCT USE

20070701-EN

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
 In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.).These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in his document shall be made at the customer's own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patents or other rights of TOSHIBA or the third parties.
- GaAs(Gallium Arsenide) is used in this product. The dust or vapor is harmful to the human body. Do not break, cut, crush or dissolve chemically.
- Please contact your sales representative for product-by-product details in this document regarding RoHS compatibility. Please use these products in this document in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses occurring as a result of noncompliance with applicable laws and regulations.